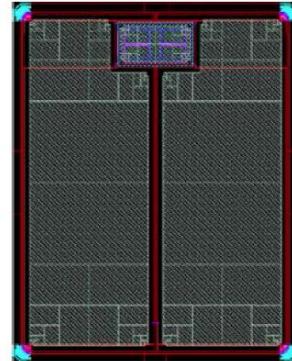


## Description

Silicon Carbide (SiC) MOSFET use a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operating frequency, increased power density, reduced EMI, and reduced system size.

## Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low RDS(on)
- Easy to parallel and simple to drive
- ROHS Compliant, Halogen free



## Application

- EV motor drive
- High Voltage DC/DC Converters
- Switch Mode Power Supplies
- Solar inverters
- EV charging

● Part Number	Die Size
MSM065012B	5.080×6.388

**Absolute Maximum Ratings(Tc=25 °C)**

<b>Symbol</b>	<b>Parameter</b>	<b>Value</b>	<b>Unit</b>
V <sub>DS</sub>	Drain-Source Voltage	650	V
I <sub>D</sub>	Drain Current(continuous)at Tc=25°C	150	A
I <sub>D</sub>	Drain Current(continuous)at Tc=100°C	100	A
I <sub>DM</sub>	Drain Current (pulsed)	300	A
V <sub>GS</sub>	Gate-Source Voltage	-10/+22	V
P <sub>D</sub>	Power Dissipation T <sub>C</sub> = 25°C	550	W
T <sub>J</sub> , T <sub>stg</sub>	Junction and Storage Temperature Range	-55 to +175	°C

**Electrical Characteristics(T<sub>J</sub> = 25 °C unless otherwise specified)****Typical Performance-Static**

<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
BV <sub>DS</sub>	Drain-source Breakdown Voltage	I <sub>D</sub> =250uA, V <sub>GS</sub> =0V	650			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C			100	uA
I <sub>GSS</sub>	Gate-body Leakage Current	V <sub>DS</sub> =0V ; V <sub>GS</sub> =-10 to 20V			250	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =22mA	2	3	4	V
V <sub>Gson</sub>	Recommended turn-on Voltage	Static		18		V
V <sub>Gsoff</sub>	Recommended turn-off Voltage			-5		V
R <sub>Ds(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> =18V, I <sub>D</sub> =75A		12	20	mΩ
		V <sub>GS</sub> =18V, I <sub>D</sub> =75A T <sub>J</sub> =175°C		16		mΩ

**Typical Performance-Dynamic**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input Capacitance	$V_{DS}=400V, f=1MHz$ , $V_{AC}=25mV$		7169		pF
$C_{oss}$	Output Capacitance			325		pF
$C_{rss}$	Reverse Transfer Capacitance			31		pF
$g_{fs}$	Transconductance	$V_{DS}=20V, I_D=15A$		42		S
$E_{oss}$	$C_{oss}$ Stored Energy	$V_{DS}=400V, f=1MHz$		32		$\mu J$
$E_{ON}$	Turn-On Energy (Body Diode)	$V_{DS}=400V, V_{GS}=-5/20V$ , $I_D=50A, L=60\mu H$ $T_J=175^\circ C$		436		$\mu J$
$E_{OFF}$	Turn-Off Energy (Body Diode)			287		$\mu J$
$Q_g$	Total Gate Charge	$V_{DS}=400V, V_{GS}=-5V/20V$ , $I_D = 50 A$		236		nC
$Q_{gs}$	Gate-source Charge			56		nC
$Q_{gd}$	Gate-Drain Charge			64		nC
$R_{G(int)}$	Internal Gate Resistance	$f=1MHz, V_{AC}=25mV$		2.2		$\Omega$
$t_{d(on)}$	Turn-on Delay Time	$V_{DS}=400V, V_{GS}=-5V/20V$ , $I_D = 50A, L=60 \mu H$ $R_{ext}=5\Omega$		26		ns
$t_r$	Rise Time			35		ns
$t_{d(off)}$	Turn-off Delay Time			63		ns
$t_f$	Fall Time			17		ns

**Typical Performance-Reverse Diode( $T_J = 25^\circ C$  unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{FSD}$	Forward Voltage	$V_{GS}=0V, I_F=50A, T_J=25^\circ C$		3.5	6	V
		$V_{GS}=0V, I_F=50A, T_J=175^\circ C$		3.0	6	V
$I_S$	Continuous Diode Forward Current	$V_{GS}=0V, T_C=25^\circ C$		80		A
$t_{rr}$	Reverse Recovery Time	$V_{GS}=-5 V, I_F=50 A$ , $V_R=400 V, T_J=175^\circ C$ $dI/dt=2400 A/\mu s$		88		nS
$Q_{rr}$	Reverse Recovery Charge			680		nC
$I_{rrm}$	Peak Reverse Recovery Current			17		A

**Mechanical Parameters**

Parameter	Typical Value	Unit
Die Dimensions (L×W) without scribe line	5.00×6.308	mm
Gate Pad Dimensions (L×W)	1.18×0.6	mm
Source Pad Metal Dimensions (LxW) Each	2.038×5.690×2	mm
Scribe Line	80	um
Die Thickness	175±25	um
Top Side Source metallization (Al)	4	um
Top Side Gate metallization (Al)	4	um
Bottom Drain metallization (Ti/Ni/Ag)	0.2/0.3/2	um

**Chip Dimensions**